Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/810,871	HAYES, EDWIN "M"
Examiner	Art Unit
Christopher Verdier	3745

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	TES I STRATEGY	<b>'</b> )
	DATE	EXMR
Inventor Name search	5/27/05	W
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